

# +5 Volt Electronic eFuse

## NIS6350, NIV6350

The NIS6350 is a cost effective, resettable fuse which can greatly enhance the reliability of a USB application from both catastrophic and shutdown failures.

It is designed to buffer the load device from excessive input voltage which can damage sensitive circuits and to protect the input side circuitry from reverse currents. It includes an overvoltage clamp circuit that limits the output voltage during transients but does not shut the unit down, thereby allowing the load circuit to continue its operation.

### Features

- 85 mΩ Max  $R_{DS(on)}$
- Integrated Reverse Current Protection
- Adjustable Output Current Limit Protection with Thermal Shutdown
- IEC61000-4-2 Level 4 ESD Protection for  $V_{bus}$  up to  $\pm 7$  kV
- Fast Response Overvoltage Clamp Circuit with Selectable Level
- Internal Undervoltage Lockout Circuit
- Digital Enable with Separate FLAG for Fault Identification
- Integrated Current Monitoring
- Both Latching and Auto-Retry Options Available
- NIV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

### Typical Applications

- Automotive Infotainment
- USB 2.0/3.0/3.1 VBUS
- USB Type-C PD Charging
- Solid State Drives
- Mother Boards



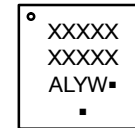
**ON Semiconductor®**

[www.onsemi.com](http://www.onsemi.com)



**WDFNW10, 3 x 3  
CASE 515AB**

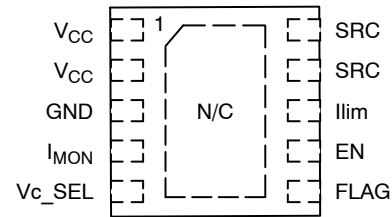
### MARKING DIAGRAM



- A = Assembly Location
- L = Wafer Lot
- Y = Year
- W = Work Week
- = Pb-Free Package

(Note: Microdot may be in either location)

### PIN CONNECTIONS



(Top View)

### ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

# NIS6350, NIV6350

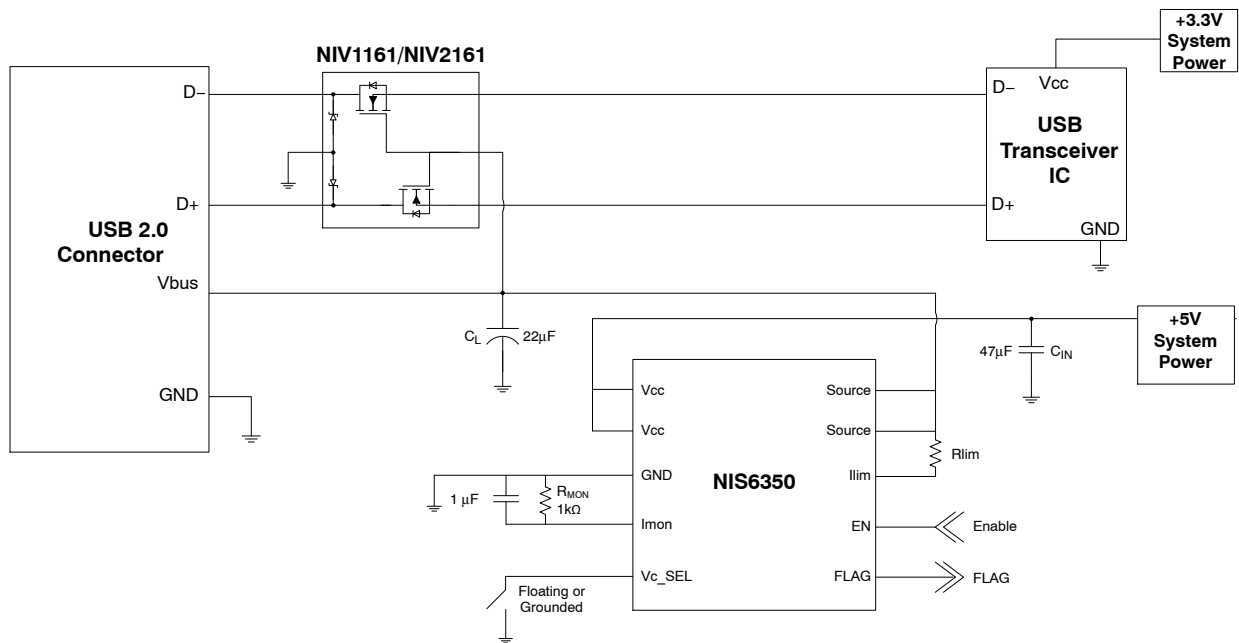


Figure 1. Typical USB 2.0 Application Circuit



Figure 2. Block Diagram

## PIN FUNCTION DESCRIPTION

Pin No.	Pin Name	Description
1, 2	V <sub>CC</sub>	Positive input voltage to the device. (Low ESR capacitor of minimum 47 µF from V <sub>CC</sub> to GND is required)
3	GND	Negative input voltage to the device. This is used as the internal reference for the IC.
4	I <sub>MON</sub>	This pin can be used to monitor the output current by using an external pull-down resistor and de-coupling capacitor.
5	V <sub>c_SEL</sub>	The V <sub>c_SEL</sub> pin allows the overvoltage clamp to be set at either a 5.6 V or 6.2 V minimum.
6	FLAG	If a thermal fault occurs, the voltage on this pin will go to a low state to signal a monitoring circuit that the device is in thermal shutdown.
7	EN	When this pin is pulled low the eFuse is turned off. It can be used to enable or disable the output of the device by pulling it to ground using an open drain or open collector device, as it has an internal pull-up.
8	I <sub>lim</sub>	A resistor between this pin and the source pin sets the overload and short circuit current limit levels.
9, 10	Source	Source of the internal power FET and the output terminal of the fuse
11	N/C (EP)	(Exposed Pad) This pad to be used as heatsink only with no electrical connection. It should be connected to a large area of copper on the PCB, or to the PCB's GND plane.

# NIS6350, NIV6350

## MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Input Voltage, operating, steady-state ( $V_{CC}$ to GND) Transient (100 ms)	$V_{CC}$	-0.3 to +10	V
		-0.3 to +10	
Output Voltage, operating, steady-state (SRC to GND)	$V_{OUT}$	-0.3 to +20	V
Voltage range on ILIM pin	$V_{ILIM}$	-0.3 to +20	V
Voltage range on Enable pin	$V_{EN}$	-0.3 to 5	V
Voltage range on FLAG pin	$V_{FLAG}$	-0.3 to 6	V
Voltage range on all other pins		-0.3 to 5	V
Electrostatic Discharge Human Body Model (All pins) Charged Device Model (All pins) IEC61000-4-2 Contact (Source pins, with 22 $\mu$ F $C_{SOURCE}$ condition)	ESD	$\pm 2$ $\pm 1$ $\pm 7$	kV

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL RATINGS

Rating	Symbol	Value	Unit
Thermal Resistance, Junction-to-Air (4 layer High-K JEDEC JESD51-7 PCB, 100 mm <sup>2</sup> , 2 oz. Cu)	$\theta_{JA}$	95	°C/W
Thermal Characterization Parameter, Junction-to-Lead (4 layer High-K JEDEC JESD51-7 PCB, 100 mm <sup>2</sup> , 2 oz. Cu)	$\psi_{J-L}$	21	°C/W
Thermal Characterization Parameter, Junction-to-Board (4 layer High-K JEDEC JESD51-7 PCB, 100 mm <sup>2</sup> , 2 oz. Cu)	$\psi_{J-B}$	13	°C/W
Thermal Characterization Parameter, Junction-to-Top (4 layer High-K JEDEC JESD51-7 PCB, 100 mm <sup>2</sup> , 2 oz. Cu)	$\psi_{J-T}$	5	°C/W
Total Continuous Power Dissipation @ $T_A = 25^\circ\text{C}$ (4 layer High-K JEDEC JESD51-7 PCB, 100 mm <sup>2</sup> , 2 oz. Cu) Derate above 25°C	$P_{max}$	1.3	W
		10.4	mW/°C
Operating Ambient Temperature Range	$T_A$	-40 to 125	°C
Operating Junction Temperature Range	$T_J$	-40 to 150	°C
Non-operating Temperature Range	$T_{STG}$	-55 to 155	°C
Lead Temperature, Soldering (10 Sec)	$T_L$	260	°C

# NIS6350, NIV6350

**ELECTRICAL CHARACTERISTICS** (Unless otherwise noted:  $V_{CC} = 5\text{ V}$ ,  $C_L = 22\ \mu\text{F}$ ,  $R_{\text{limit}} = 15\ \Omega$ ,  $T_A = -40\text{ to }125^\circ\text{C}$ )

Characteristics	Symbol	Min	Typ	Max	Unit
-----------------	--------	-----	-----	-----	------

## POWER FET

Delay Time (enabling of chip to $I_D = 100\text{ mA}$ with $5\ \Omega$ resistive load)	$T_{\text{dly}}$		1500		$\mu\text{s}$
ON Resistance (Note 1)	$R_{\text{DS(on)}}$		36	85	$\text{m}\Omega$
$T_J = 140^\circ\text{C}$ (Note 2)			58		
Continuous Current $T_A = 25^\circ\text{C}$ (Note 2)	$I_d$			3	A
Off State Leakage ( $V_{\text{in}} = 5\text{ V}$ , $\text{EN} = 0$ )	$I_{\text{OFF\_LEAK}}$			1	$\mu\text{A}$

## THERMAL LATCH

Shutdown Temperature (Note 3)	$T_{\text{SD}}$	150	175	200	$^\circ\text{C}$
-------------------------------	-----------------	-----	-----	-----	------------------

## UNDER/OVERVOLTAGE PROTECTION

$V_{\text{OUT}}$ Maximum ( $V_{\text{CC}} = 10\text{ V}$ with $V_{\text{c\_SEL}}$ pin floating)	$V_{\text{out-clamp}}$	6.2	6.9	7.5	V
$V_{\text{OUT}}$ Maximum ( $V_{\text{CC}} = 10\text{ V}$ with $V_{\text{c\_SEL}}$ pin pulled low (0V))	$V_{\text{out-clamp}}$	5.6	6.1	6.5	V
Over Voltage Response Time	$T_{\text{vout-clamp}}$		11	20	$\mu\text{s}$
Undervoltage Lockout (Turn on, Voltage Going High)	$V_{\text{UVLO}}$	3.4	3.8	4.6	V
UVLO Hysteresis	$V_{\text{Hyst}}$		0.35		V
Under Voltage Response Time, VCC Falling, $-5\text{ V/ms}$	$T_{\text{uvlo}}$		2	6	$\mu\text{s}$
Under Voltage Response, VCC Rising, $+5\text{ V/ms}$			5	10	$\mu\text{s}$

## CURRENT LIMIT

Current Limit	$I_{\text{OL}}$		3.0		A
Short Circuit Current	$I_{\text{sc}}$	0.6	0.9	1.2	A
Current Limit Response Time	$T_{\text{ilim}}$		2.0	10	$\mu\text{s}$

## REVERSE CURRENT LIMIT

Reverse current blocking threshold ( $V_{\text{out}} - V_{\text{in}}$ ) (Note 4)	$V_{\text{rev-th}}$	25	100	250	mV
Reverse current limit response time ( $dV_{\text{in}}/dt = -5\text{ V/1 ms}$ , $20\ \mu\text{F}$ Load)	$V_{\text{rev-resp}}$	4	7	12	$\mu\text{s}$

## SLEW RATE CONTROL

Slew Rate	SR		1	3	ms
-----------	----	--	---	---	----

## CURRENT MONITOR

No Load Current ( $\text{EN} = \text{high}$ , $I_{\text{load}} = 0\text{ A}$ )	$I_{\text{mon-o}}$	0	100	200	$\mu\text{A}$
Gain ( $I - I_{\text{MON}}/I_{\text{out}}$ , @ $I_{\text{out}} = 1\text{ A}$ , $R_{\text{MON}} = 1\text{ k}\Omega$ , $C_{\text{MON}} = 1\ \mu\text{F}$ )	$I_{\text{mon-gain}}$	0.9	1.0	1.1	$\text{mA/A}$

## ENABLE

Logic Level Low (Output Disabled)	$V_{\text{in-low}}$			0.4	V
Logic Level High (Output Enabled) (Note 5)	$V_{\text{in-high}}$	1.1			V
High State Maximum Voltage	$V_{\text{in-max}}$			5	V
Logic Low Sink Current ( $V_{\text{EN}} = 0\text{ V}$ )	$I_{\text{in-low}}$		15	35	$\mu\text{A}$
De-glitch Filter-delay	Filter-delay	2	10	50	$\mu\text{s}$

## FLAG

Fault Output Low Voltage (Fault Detected)	Fault-low			0.7	V
Fault Output High Voltage (No Fault Detected)	Fault-high	2.5		5.0	V
Logic High Source Current	Flag- $I_{\text{OH}}$		60		$\mu\text{A}$
Maximum Fan Out for Fault Signal (guaranteed by design)	Fan			2	Units

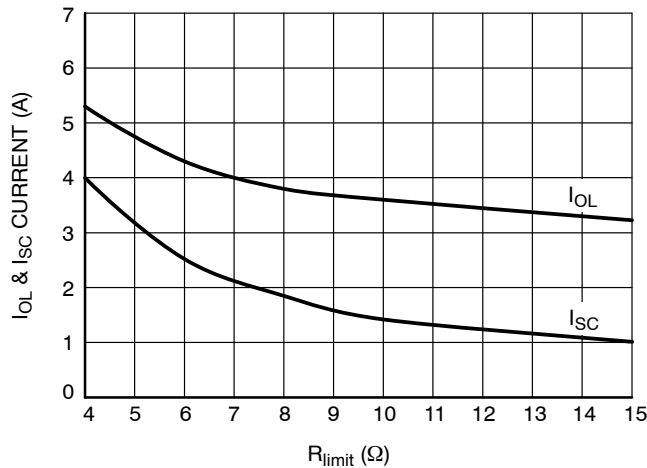
# NIS6350, NIV6350

**ELECTRICAL CHARACTERISTICS** (Unless otherwise noted:  $V_{CC} = 5\text{ V}$ ,  $C_L = 22\ \mu\text{F}$ ,  $R_{\text{limit}} = 15\ \Omega$ ,  $T_A = -40\text{ to }125^\circ\text{C}$ )

Characteristics	Symbol	Min	Typ	Max	Unit
<b>TOTAL DEVICE</b>					
Bias Current	$I_{\text{Bias}}$				$\mu\text{A}$
Operational ( $I_{\text{Load}} = 0\text{ A}$ , $\text{EN} = 1$ , $\text{FLAG} = \text{high}$ )			300	800	
Shutdown ( $\text{EN} = 0$ )			100	200	
Thermal Fault			100	200	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. Pulse test: Pulse width 300 s, duty cycle 2%
2. Verified by design.
3. eFuse is latched off until the En/Fault pin is pulled low and then released or a power on reset is applied to the device. If an auto-retry part is used the device will automatically attempt to turn on once the internal temperature is less than  $135^\circ\text{C}$ .
4. Once the device has entered shutdown mode due to a reverse current event, it will re-enable its output when  $V_{\text{IN}} > V_{\text{OUT}}$  for at least  $100\ \mu\text{s}$ . The slew rate SR will be applied when the output is re-enabled.
5. A voltage level higher than  $V_{\text{in-high min}}$  (1.1 V) must be present to ensure a Logic Level High on the Enable pin.



**Figure 3. Current Limit vs.  $R_{\text{limit}}$  for Direct Current Sensing**

APPLICATIONS INFORMATION

**Basic Operation**

This device is a self-protected, resettable, electronic fuse. It contains circuits to monitor the input voltage, output voltage, output current and die temperature.

On application of the input voltage, the device will apply the input voltage to the load based on the restrictions of the controlling circuits. The output voltage, which is controlled by an internal dv/dt circuit, will slew from 0 V to the rated output voltage in 1 ms.

The device will remain on as long as the temperature does not exceed the 175°C limit that is programmed into the chip.

The internal current limit circuit does not shut down the part but will reduce the conductivity of the FET to maintain a constant current at the internally set current limit level. The input overvoltage clamp also does not shutdown the part, but will limit the output voltage in the event that the input exceeds the Vclamp level. This operation can be seen in Figure 5.

An internal charge pump provides bias for the gate voltage of the internal n-channel power FET and also for the current limit circuit. The remainder of the control circuitry operates between the input voltage (VCC) and ground.

The VCC line can generate spike noise in fast transient conditions such as short circuit, and this high peak can cause over-stress and malfunction. To prevent this, a low ESR capacitor (i.e. MLCC) of at least 47 µF is required.

**Reverse Current Protection**

The NIS6350 monitors and protects against reverse current events, which can be the result of a malfunction in the power supply or noise induced in the input voltage rail under certain load characteristics (for example, when the load is largely capacitive).

The protection mechanism disables the eFuse’s output and triggers when the reverse voltage drop exceeds 100 mV in magnitude and this condition remains for at least 4 µs.

The NIS6350 automatically re-enables its output once the input voltage exceeds the output voltage for at least 100 µs.

**Overvoltage Clamp**

The overvoltage clamp consists of an amplifier and reference. It monitors the output voltage and if the input voltage exceeds the Vclamp voltage, the gate drive of the main FET is reduced to limit the output. This is intended to allow operation through transients while protecting the load. If an overvoltage condition exists for many seconds, the device may overheat due to the voltage drop across the FET combined with the load current. In this event, the thermal protection circuit would shut down the device.

The Vc\_SEL pin can be used to select the Vclamp level. By allowing this pin to float high, the Vclamp value will be set to 6.2 – 7.5 V. By pulling this pin low (to 0V), the Vclamp value will be set to 5.6 – 6.5 V. This allows the NIS6350 to

be used in both short and long haul USB applications where the VBUS voltage is adjusted for cable loss compensation. This operation can be seen in Figure 5.

**Thermal Protection**

The NIS6350 includes an internal temperature sensing circuit that senses the temperature on the die of the power FET. If the temperature reaches 175°C, the device will shut down, and remove power from the load. If a latching device is used, output power can be restored by either recycling the input power or toggling the enable pin. An auto-retry device will automatically try to restore output power on its own.

The thermal limit has been set high intentionally, to increase the trip time during high power transient events.

**FLAG**

The FLAG pin sends information to other devices regarding the state of the chip. This pin is connected to an internal pull-up so that it behaves as active high. The FLAG pin remains at logic level high during normal operation and gets pulled low and subsequently turns the device off when one of the following conditions occurs:

1. EN pin set to Logic Level Low (Output Disabled)
2. Thermal fault
3. UVLO – Undervoltage Lockout
4. Reverse current fault

**Enable**

The Enable feature provides a digital interface to control the output of the eFuse. This pin is meant for push-pull operation and is connected to an internal pull-up so that it behaves as active high. When pulled low by an external circuitry (below 0.5 V), the eFuse output is turned off. Leakage current in this condition is described in the electrical characteristics table.

**IMON (Current Monitor)**

The current monitor "IMON" pin provides a small current proportional to the main device current which is passing through the device. This pin must have a decoupling capacitor to filter out internal sampling noise. A resistor connected between the IMON pin and GND converts the IMON current into a GND referenced voltage. The recommended resistor value of 1 kΩ will give about 1 V for every 1 A of device current. The IMON voltage to output current relationship is given in the below equation.

$$V_{MON} = R_{MON} \times \left( \frac{I_d}{1000} \right)$$

Although there is no maximum value that this resistor can be, the value should be limited to 3 kΩ for best operation of the IMON function. This pin can be floated if this function is not needed thus saving a few mA of leakage current.

**Latching vs. Auto-Retry**

This device features two options regarding its reset ability after a thermal shutdown event. These are called latching and auto-retry which are respectively marked MT1 and MT2 as part number suffixes. Upon reaching a thermal shutdown state, a latching device (MT1) will remain shutdown with no power supplied to the output (SRC pins). The only way to reset the device is to either perform a power cycle on the VCC bus or pull the EN pin low (<0.4 V). By doing either of these actions, the fault state is cleared and the

device is allowed to pull-up the output to its normal, high state.

Instead of remaining in thermal shutdown, an Auto-retry device (MT2) will automatically attempt to pull up the output once the die temperature cools to < 135°C. If the fault remains on the output during this attempt, the device will once again enter a short period of current limiting that will eventually lead to thermal shutdown for which the auto-retry process will repeat indefinitely.

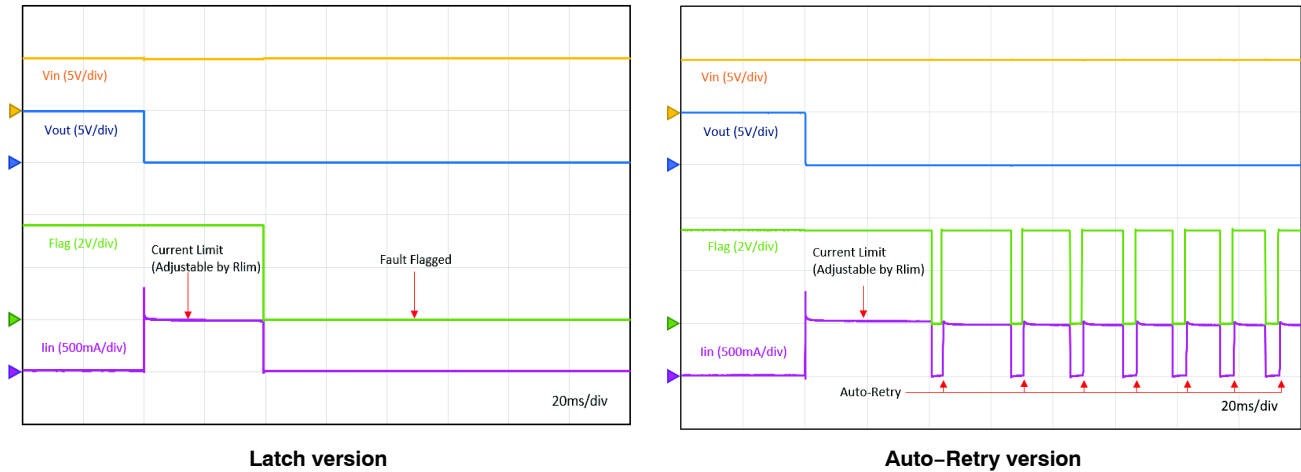
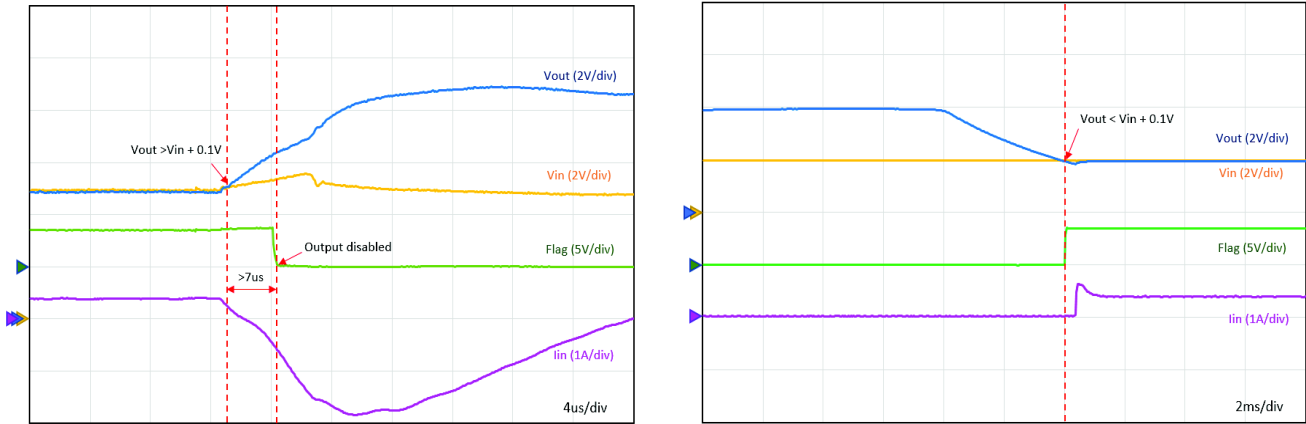


Figure 4. Output Short Circuit

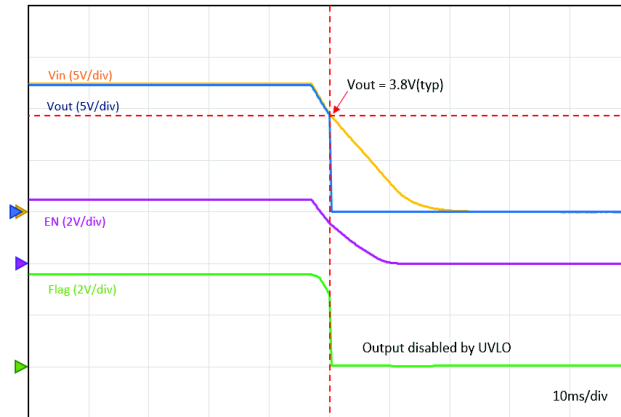


Figure 5. Output Voltage Protection

# NIS6350, NIV6350



**Figure 6. Reverse Current Protection**



**Figure 7. UVLO**

## ORDERING INFORMATION

Device	Shutdown Version	Marking	Package	Shipping†
NIS6350MT1TXG	Latching	6350	WDFNW10 (Pb-Free)	3000 / Tape and Reel
*NIV6350MT1TXG	Latching	6350		
NIS6350MT2TXG	Auto-Retry	6350H		
*NIV6350MT2TXG	Auto-Retry	6350H		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

\*NIV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable.



# MECHANICAL CASE OUTLINE

## PACKAGE DIMENSIONS

ON Semiconductor®



SCALE 2:1

### WDFNW10, 3x3, 0.5P CASE 515AB ISSUE A

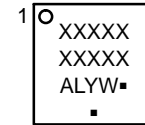
DATE 15 JUN 2018



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM THE TERMINAL TIP.
  4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
  5. THIS DEVICE CONTAINS WETTABLE FLANK DESIGN FEATURE TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	0.03	0.05
A3	0.20 REF		
A4	0.10	---	---
b	0.20	0.25	0.30
D	2.90	3.00	3.10
D2	2.40	2.50	2.60
E	2.90	3.00	3.10
E2	1.70	1.80	1.90
e	0.50 BSC		
K	0.20 REF		
L	0.30	0.40	0.50
L3	0.05 REF		

### GENERIC MARKING DIAGRAM\*

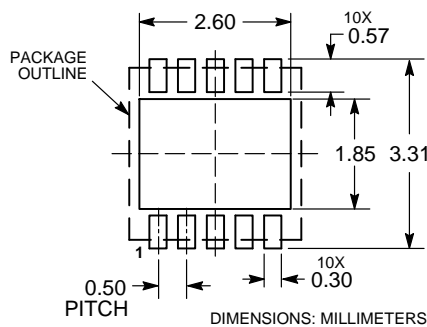


- XXXXX = Specific Device Code  
 A = Assembly Location  
 L = Wafer Lot  
 Y = Year  
 W = Work Week  
 ■ = Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

### RECOMMENDED SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

<b>DOCUMENT NUMBER:</b>	<b>98AON30588G</b>	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.
<b>DESCRIPTION:</b>	<b>WDFNW10, 3x3, 0.5P</b>	<b>PAGE 1 OF 1</b>

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

ON Semiconductor and  are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at [www.onsemi.com/site/pdf/Patent-Marking.pdf](http://www.onsemi.com/site/pdf/Patent-Marking.pdf). ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

## PUBLICATION ORDERING INFORMATION

### LITERATURE FULFILLMENT:

Email Requests to: [orderlit@onsemi.com](mailto:orderlit@onsemi.com)

ON Semiconductor Website: [www.onsemi.com](http://www.onsemi.com)

### TECHNICAL SUPPORT

North American Technical Support:  
Voice Mail: 1 800-282-9855 Toll Free USA/Canada  
Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative